


<b>Search Notes</b> 	<b>Application/Control No.</b> 10700505	<b>Applicant(s)/Patent Under Reexamination</b> NATSUKA ET AL.
	<b>Examiner</b> TAEYOON KIM	<b>Art Unit</b> 1651

SEARCHED			
Class	Subclass	Date	Examiner
435	97, 84, 41, 183	12/16/2009	TK

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
435	97, 84, 41, 183 (see attached search history)	12/16/2009	TK

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